



Let's Talk About BIPV Resilience

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**College of Engineering
and Computer Science**



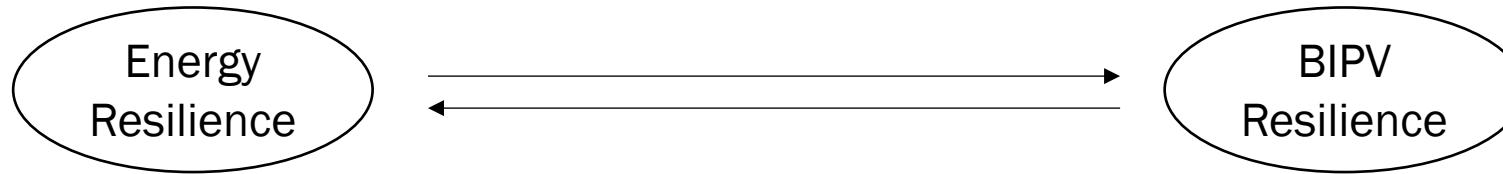
**CREOL, The College of
Optics and Photonics**



Overview

- [00:00 - 00:30](#) Introduction
- [00:30 - 03:00](#) What is BIPV Resilience and Why it's Important
- [03:00 - 06:00](#) State of Art
- [06:00 - 09:00](#) Imaging Techniques
- [09:00 - 10:00](#) Challenges and Opportunities

What is BIPV resilience



Extreme weather scenario

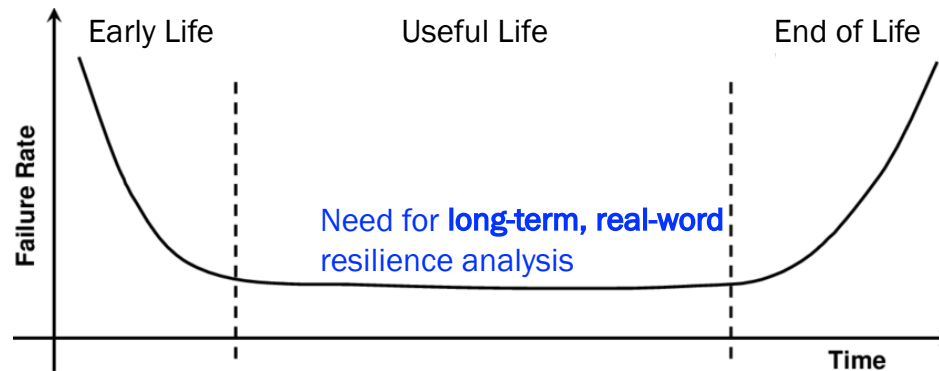
- BIPV can improve community energy resilience, by providing power, particularly during the response and recovery period
- Challenge of severe weather
 - Wind
 - Hail
 - Hurricane
 - Fire
 - Heavy snow
 - Cold & Heat shock

Normal weather scenario

- BIPV modules – only effective when deployed in direct sunlight
- Inherently harsh service environment
 - Damaging solar radiation (especially UV)
 - Heat
 - Humidity
 - Biological factors (mildew, algae, bird's dropping...)
 - Mechanical factors (sand abrasion, hail ...)

What is BIPV resilience analysis

Combining long-term field inspection and lab degradation characterizations to perform a multi-scale qualitative and quantitative analysis to understand the BIPV behavior (degradation pathway) as both a building material and PV system



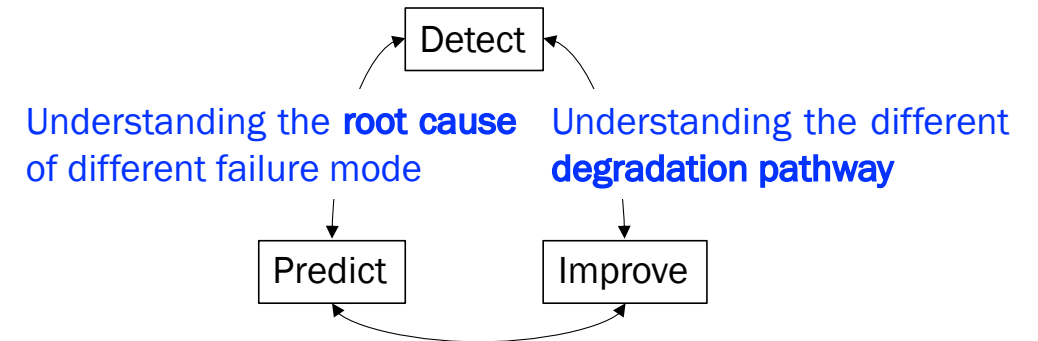
BIPV vs. BAPV vs. BIPVT ↔ PV



Least integrated
(Open rack-mounted PV)

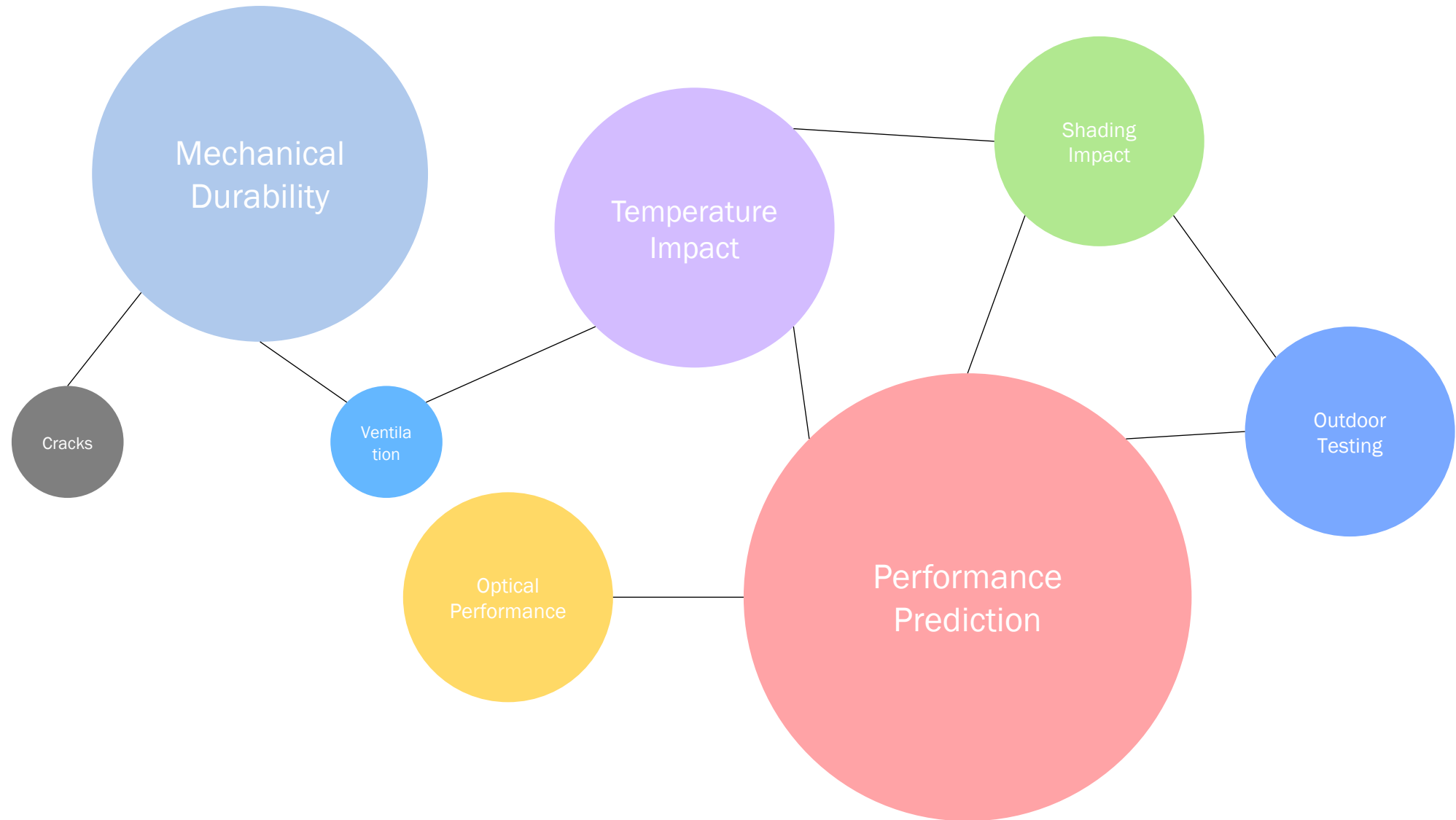
More integrated
(Close roof rack-mounted PV)

Fully integrated
(Direct-mounted BIPV,
multifunctional)

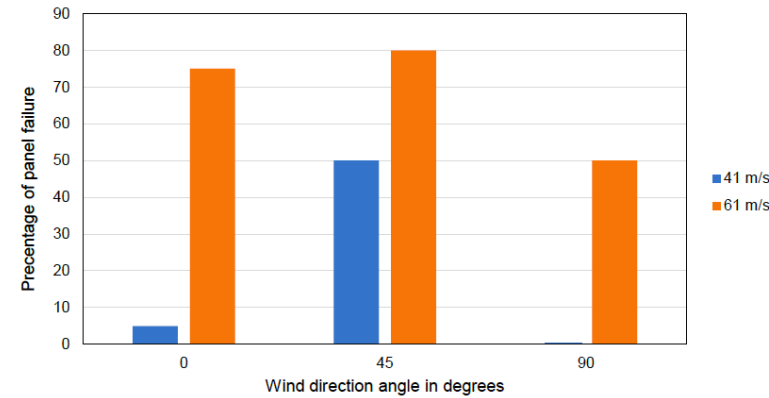
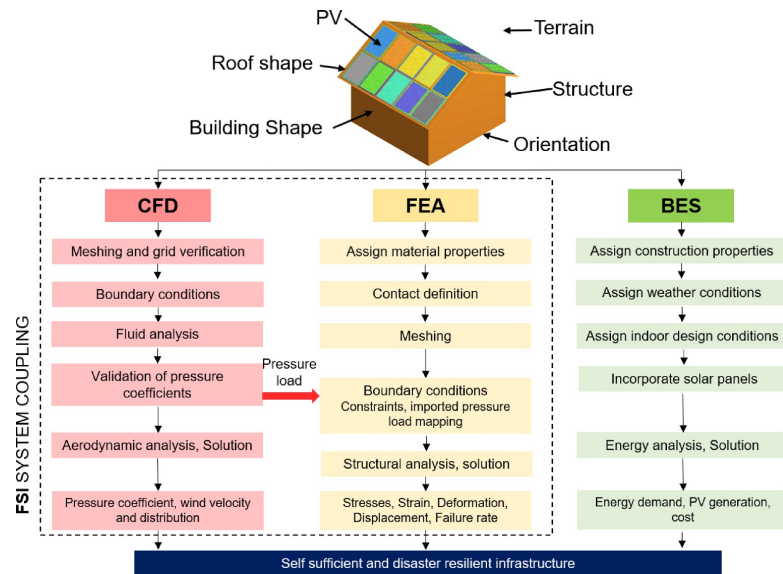


Improving **accuracy** of energy yield prediction, degradation rate calculation and provide input for techno-economic analysis, ultimately **de-risk** the investment and support **market growth**

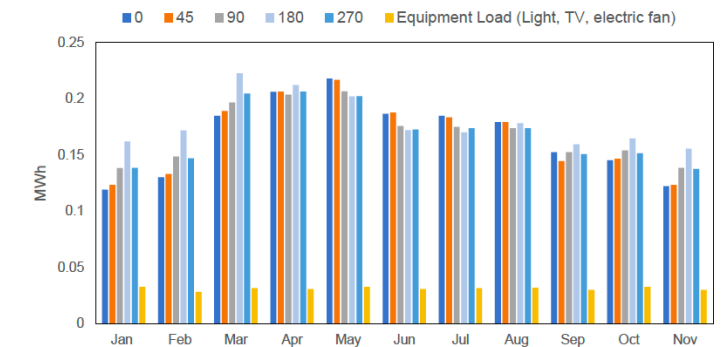
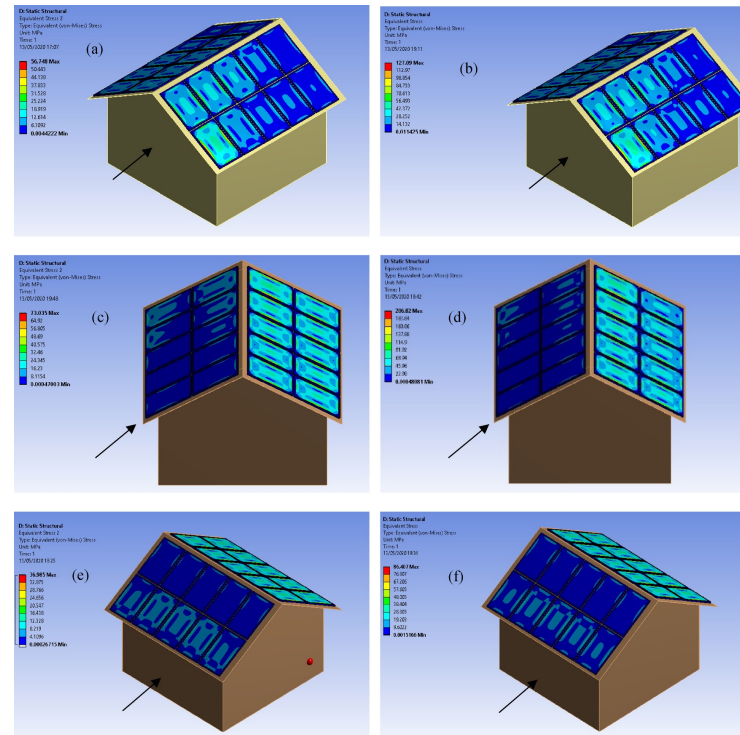
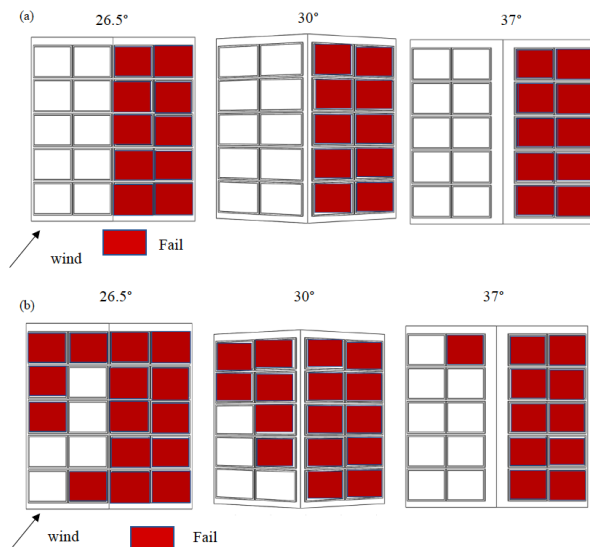
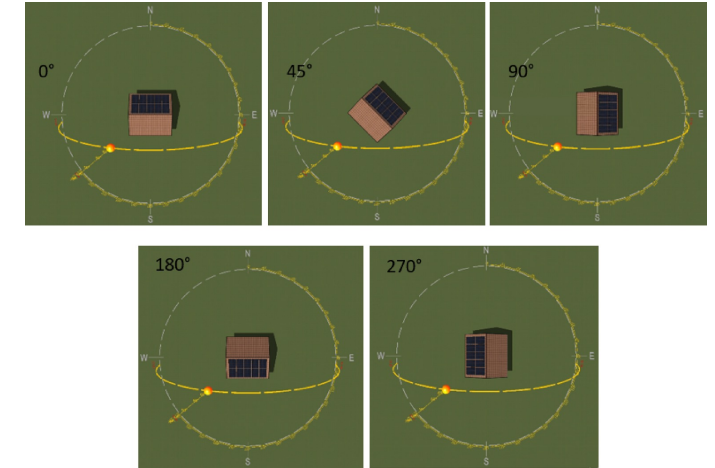
State of Art - Overview



State of art – Mechanical durability

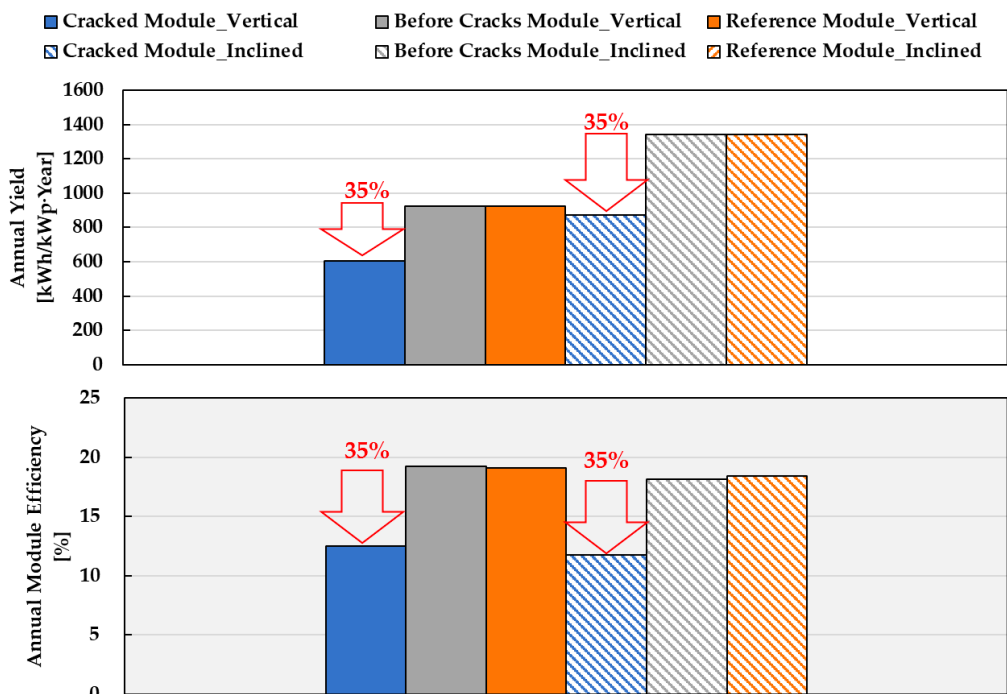
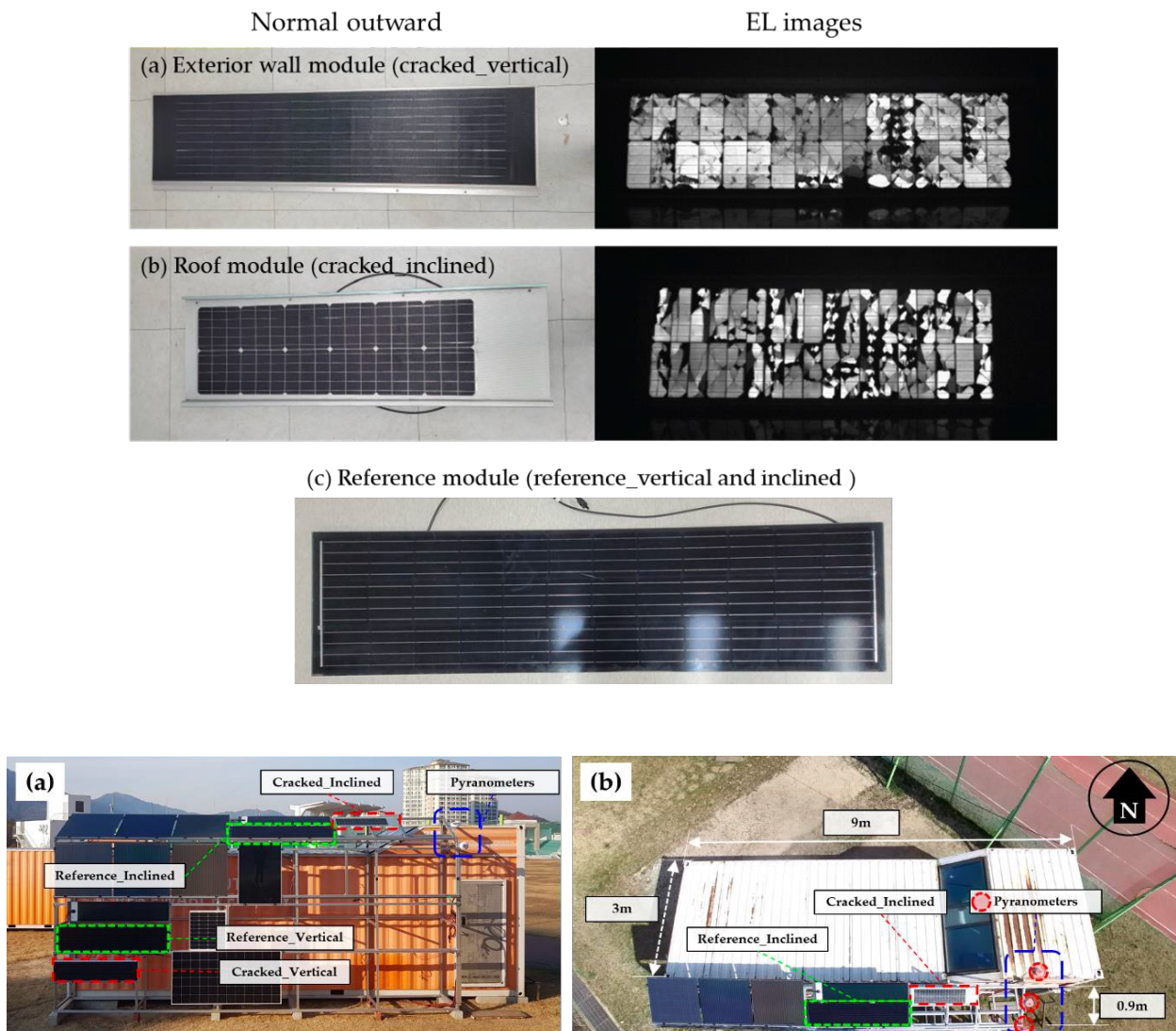


2021 C. A. J. Pantua *et al.*



State of art - Mechanical durability

2021 K. Lee *et al.*



State of art – Colored BIPV

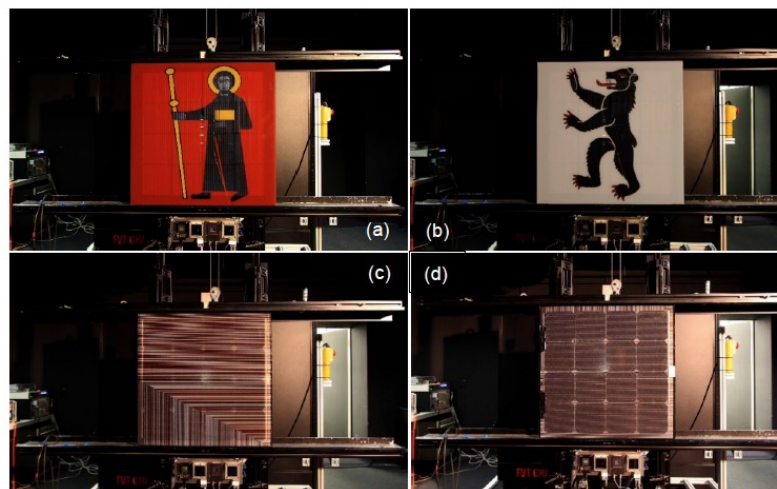


Figure 1: PV modules coloured by ceramic digital printing technology: (a) C13-A1, (b) C13-B1 and (c) & (d) front and rear side of module C13-C1.

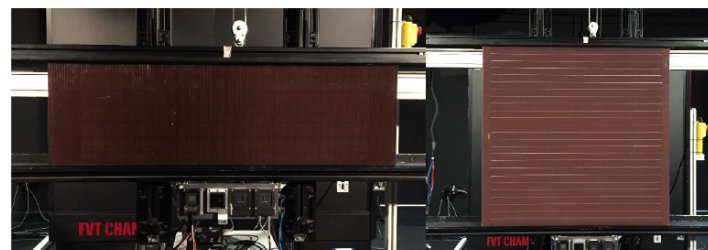


Figure 3: Two different PV modules with terracotta appearance: (left) C13-F1 module with prismatic glass and (right) C13-I1 module.

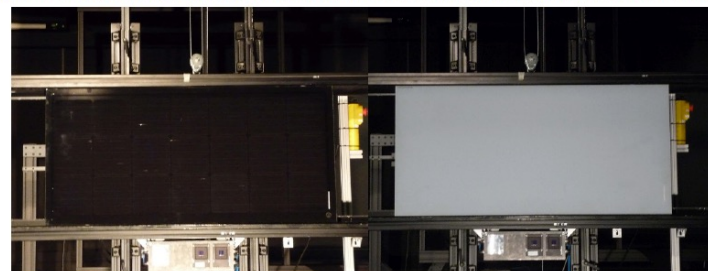
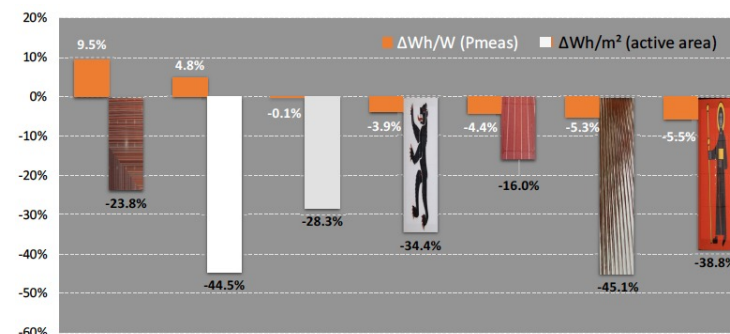
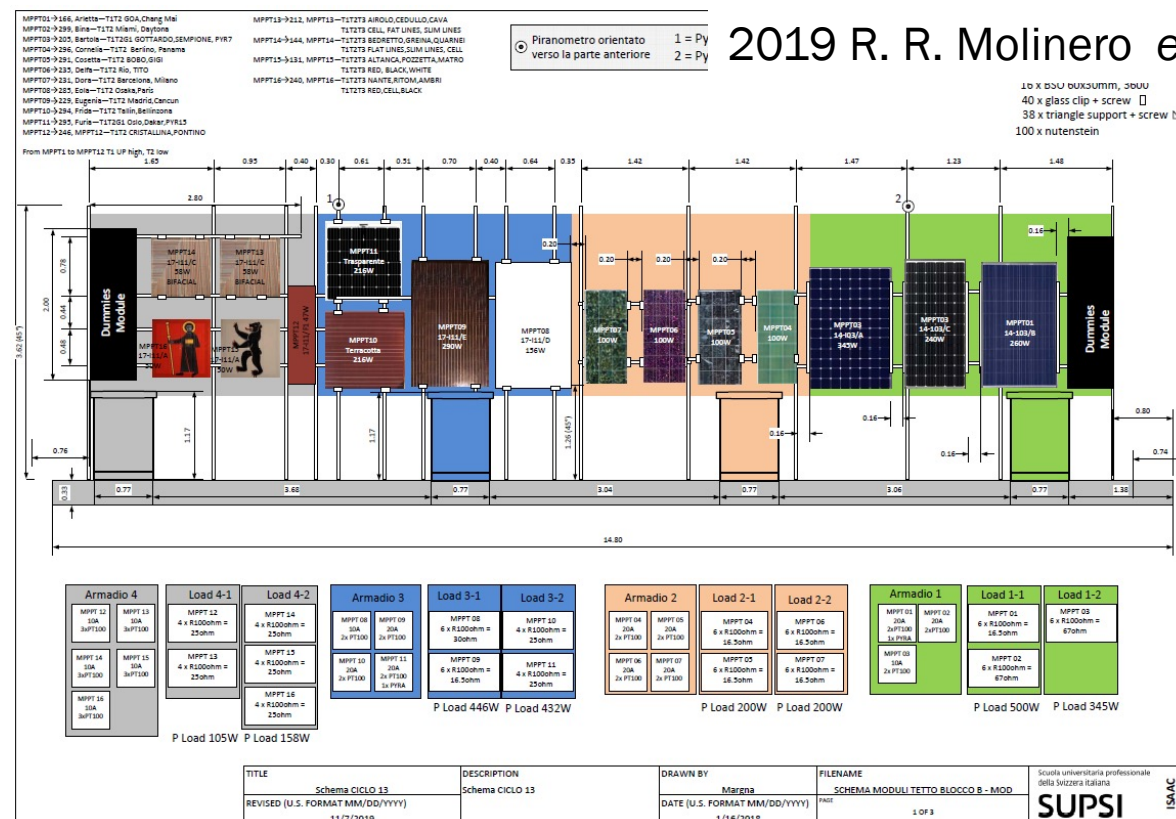
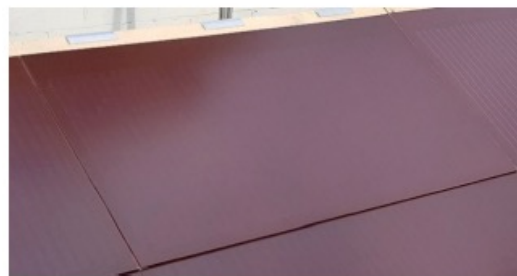


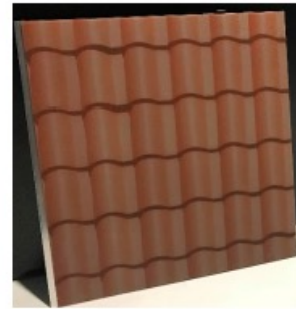
Figure 4: PV modules with full-surface printing with UV-resistant and translucent special inks: (left) C13-SA2 reference module and (right) C13-SC2 light grey module.



State of art - Colored BIPV



(a)



(b)

Figure 4. Tested modules samples: Suncol® Tile-Terracotta Simil RAL 8015 (a); and Suncol® Tile-Texturing Simil roof tile (b).

Table 2. Detail of the two tested modules typologies.

	Suncol® Tile-Terracotta	Suncol® Tile-Texturing
Solar tempered front glass	Simil RAL 8015	Simil roof tile
Active layer	18 monocrystalline cells	36 monocrystalline cells
Solar tempered back glass	Black printed	Black printed
Dimensions [m × m]	1 × 0.575	1 × 1.05

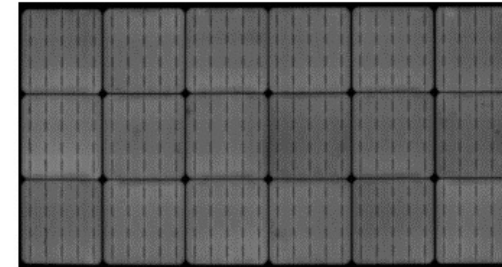


(a)

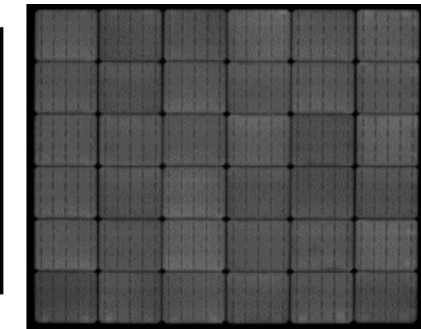


(b)

2020 M. Pelle et al.

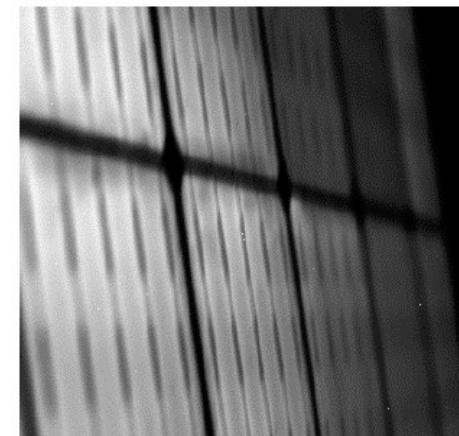


(a)



(b)

Figure 8. Electroluminescence images obtained at normal incidence shooting for: (a) Terracotta; and (b) Texturing Roof Tile.



(a)

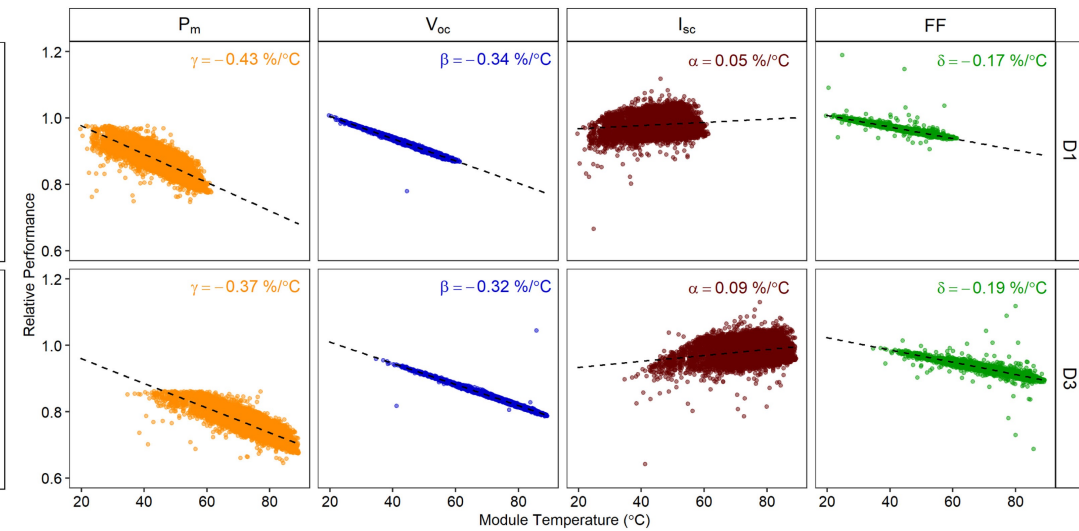
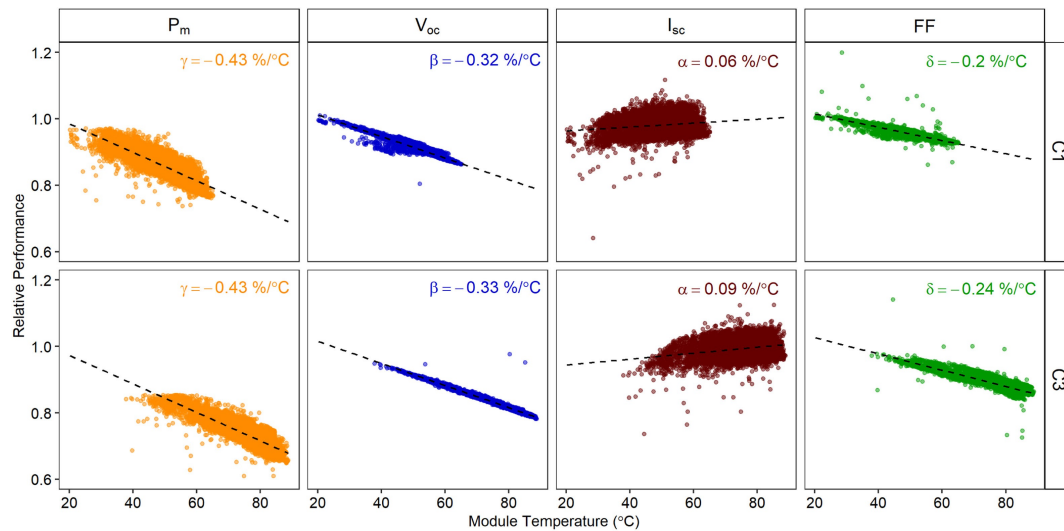
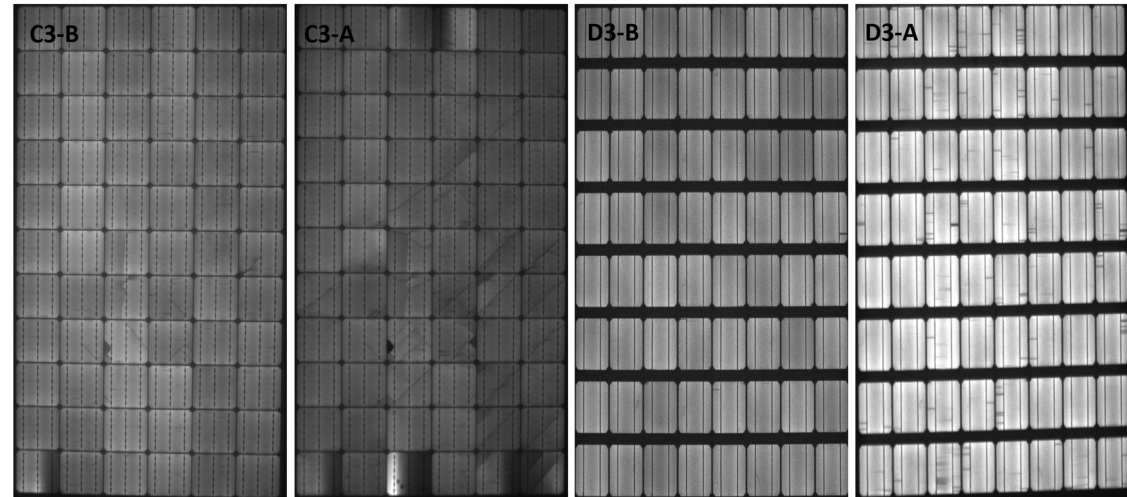


(b)

Figure 9. Electroluminescence images obtained at small incidence shooting for: (a) Terracotta; and (b) Texturing roof Tile.

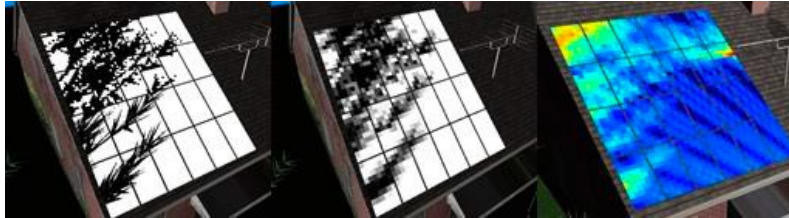
State of art – T impact

2020 A. Gok et al.

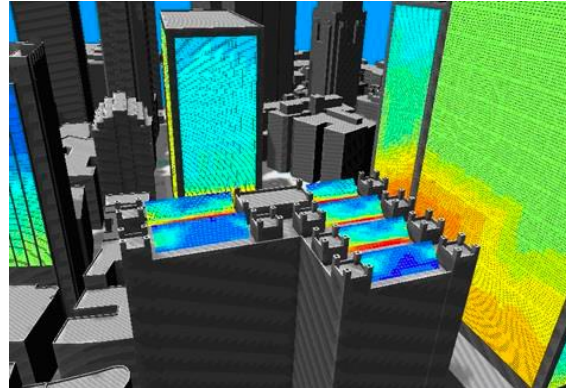


State of art – T impact, shading

Shading analysis



2019 IEA Task 15



Temperature effect

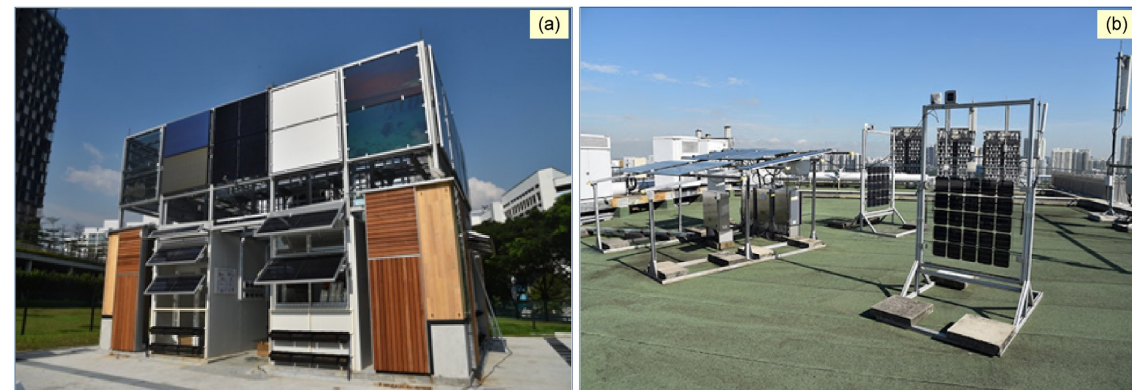
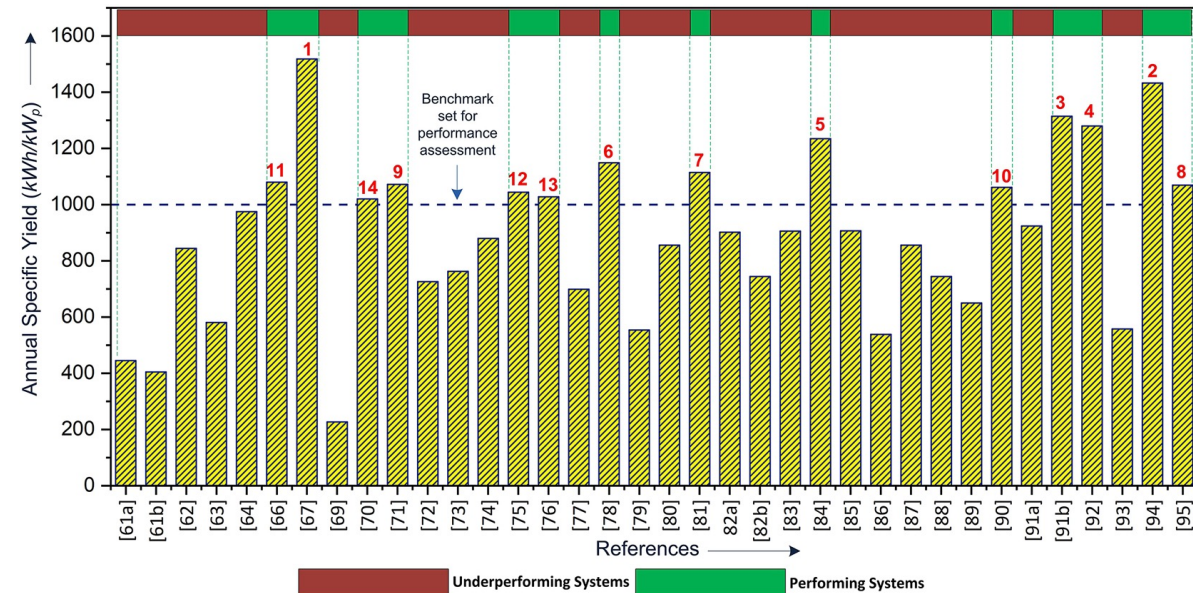
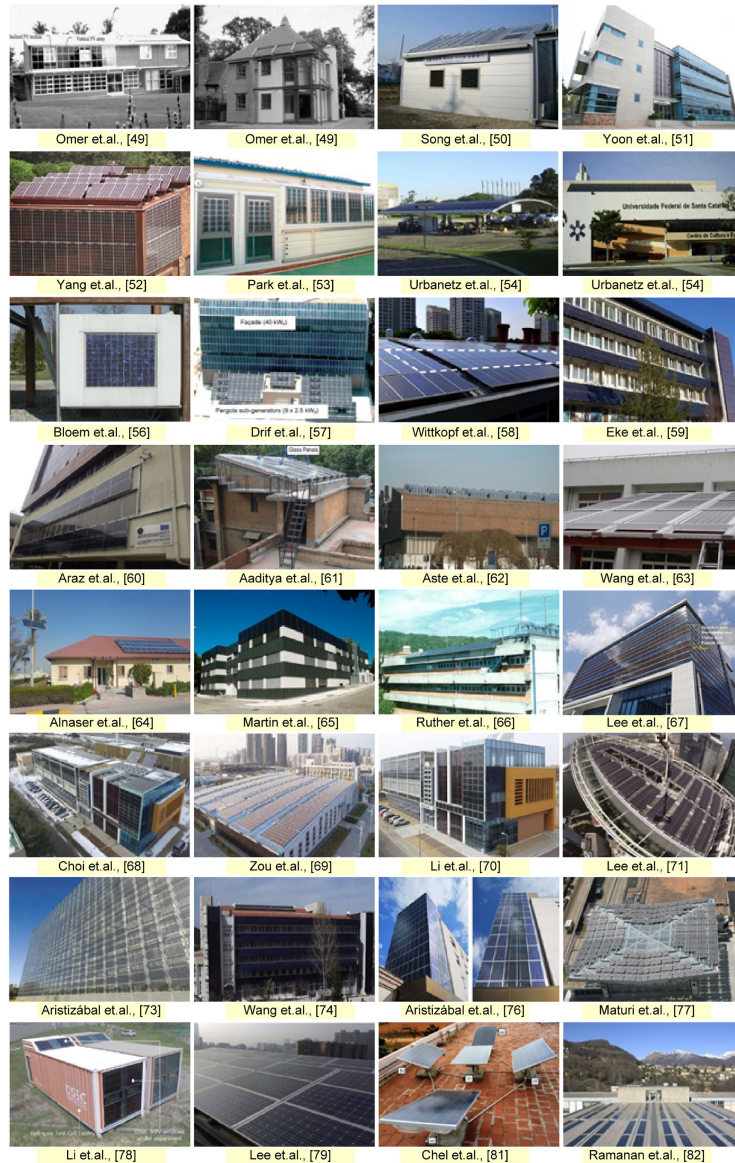
Type of tested property	Tested property	Property testing level (Module/ System)	BIPV feature to be considered	Recommended tests/procedures (including references to existing ones)
5. Durability and reliability	Thermal cycling	Module	Frequent shading	Increase number of cycles compared to standard IEC tests
5. Durability and reliability	Thermal stress	Module	Frequent partial shading (by close and distant objects)	Adapted IEC hot-spot test to new boundary conditions
5. Durability and reliability	Thermal stress	Module	Frequent partial shading (by close and distant objects)	Make IEC 62979 (bypass diode thermal runaway) mandatory if frequent shading may occur

Type of tested property	Tested property	Property testing level (Module/ System)	BIPV feature to be considered	Recommended tests/procedures (including references to existing ones)
1. Electrical	Module defect identification	Module	Inhomogeneous surface coverage	Electroluminescence testing - Mask back surface with opaque material
1. Electrical	Module defect identification	Module	Inhomogeneous surface coverage	IR imaging (problems with IR-transmissive materials like thin polymers)
1. Electrical	PID	Module	Module decoration	PID test, See Section 3.1.2.1
1. Electrical	Rated module power output	Module	Bifacial modules	Refer to IEC standardisation work on bifacial modules: Define BIPV-relevant illumination conditions for I-V measurement.
1. Electrical	Rated module power output	Module	Curved modules	Test under natural sunlight to achieve a realistic variation of incidence angles
1. Electrical	Rated module power output	Module	Large module dimensions	Test “representative-size” modules and apply extrapolation procedures; Outdoor testing; measure IV curves of individual strings within module separately
1. Electrical	Rated module power output	Module	Modules of many different dimensions	Testing “representative-size” modules and interpolation procedures
1. Electrical	Rated module power output	Module	Frequent partial shading (by close and distant objects)	Adapt IEC hot-spot test to BIPV-relevant boundary conditions
1. Electrical	Rated module power output	Module	Module decoration causing mismatch within module	Area-weighting; Optical modelling; I-V measurement
1. Electrical	Annual electricity yield	System	Treatment of front glass surface, e.g. structured, anti-reflective, anti-glare	Simulation, taking correct angular dependence of electrical data into account

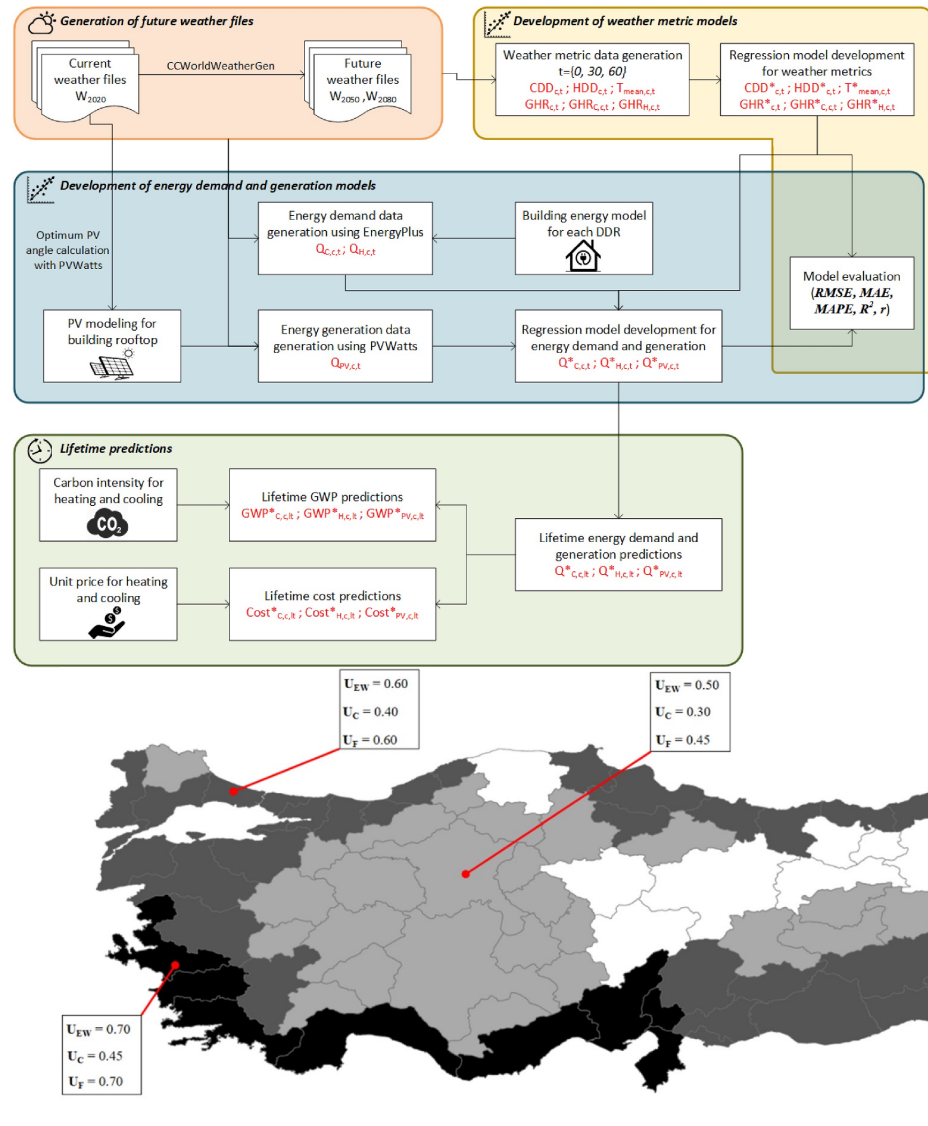
2020 IEA Task 15

State of art - Performance

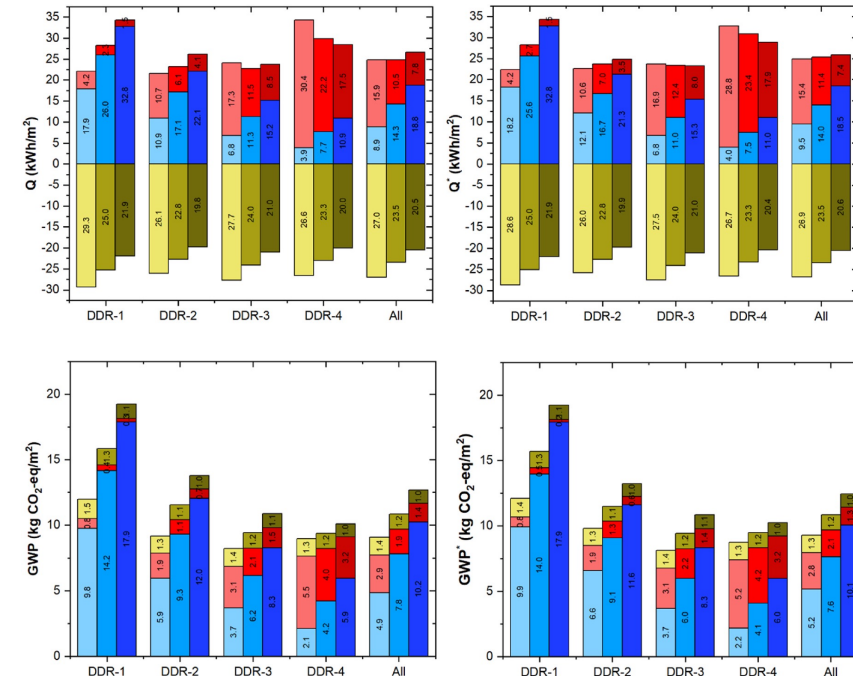
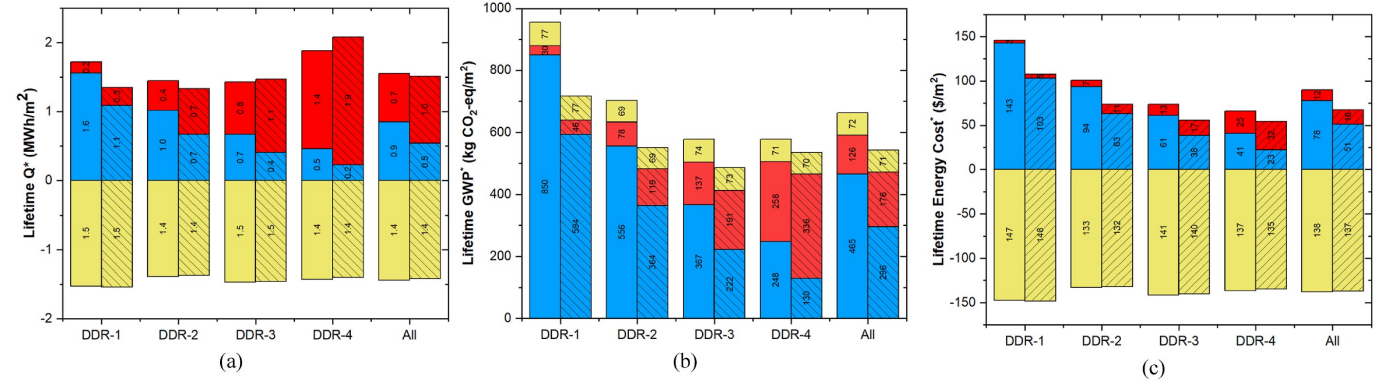
2022 D. S. Pillai et al.



State of art - Performance



2022 T. Tamer et al.

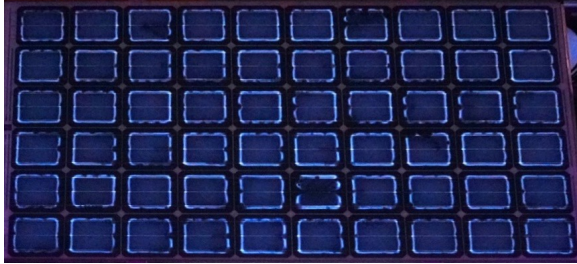


Imaging Techniques

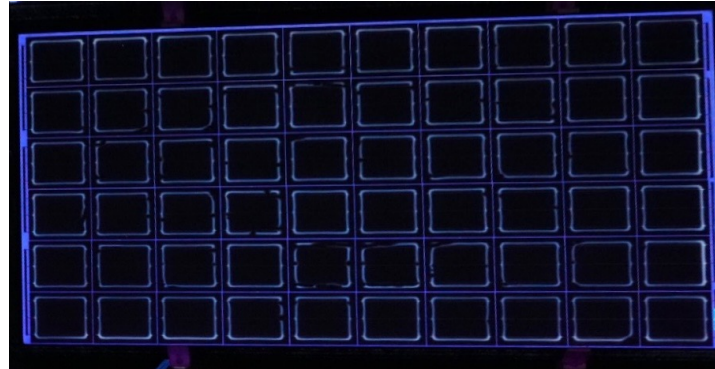
What information we can get from images?

Degradation Analysis – UVF imaging

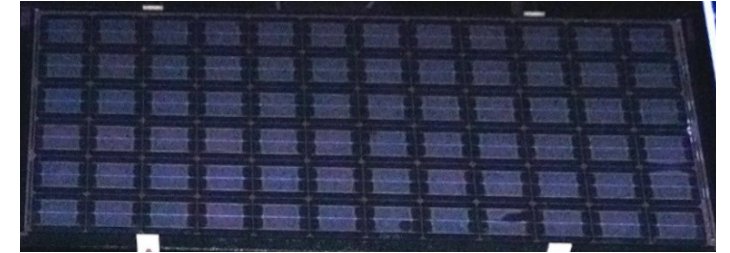
Mono AIBSF, System age = 4 years



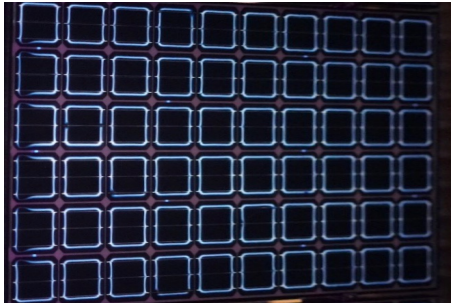
Multi AIBSF, System age = 4 years



HIT, System age = 4 years



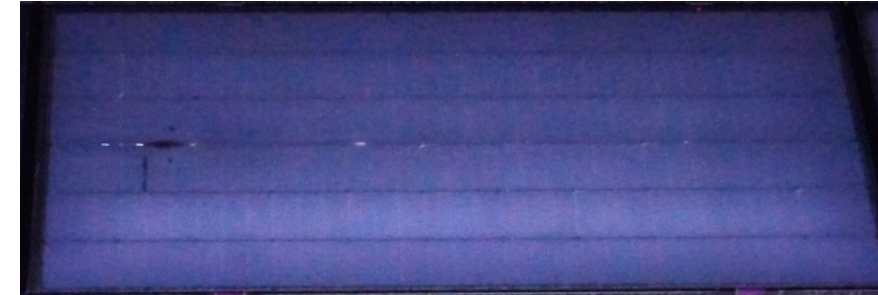
Mono AIBSF, System age = 10 years



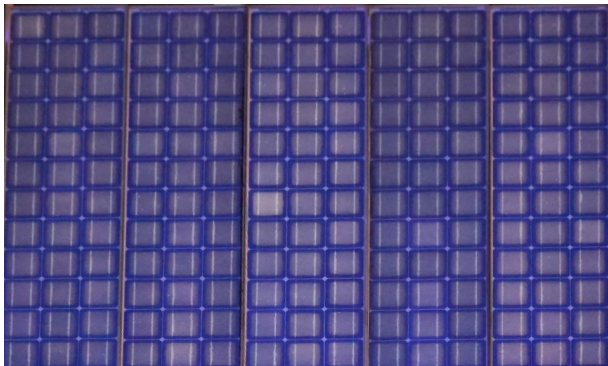
Mono PERC, System age = 4 years



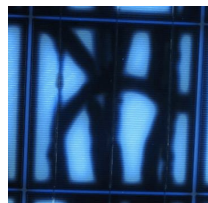
Shingle HIT, System age = 6 years



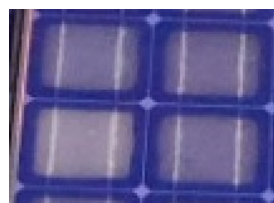
Mono AIBSF, System age = 20 years



- Cracks



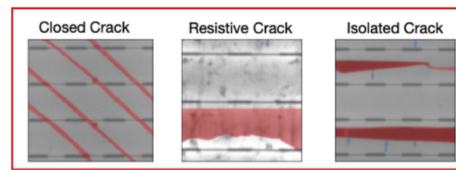
- Hot cells



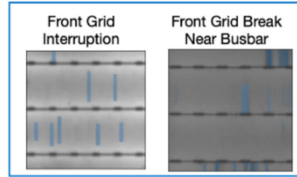
- Different BOM



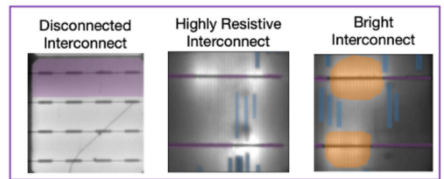
Degradation Analysis – EL imaging



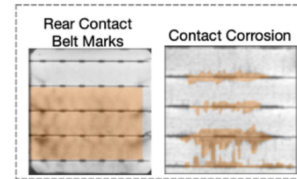
(a)



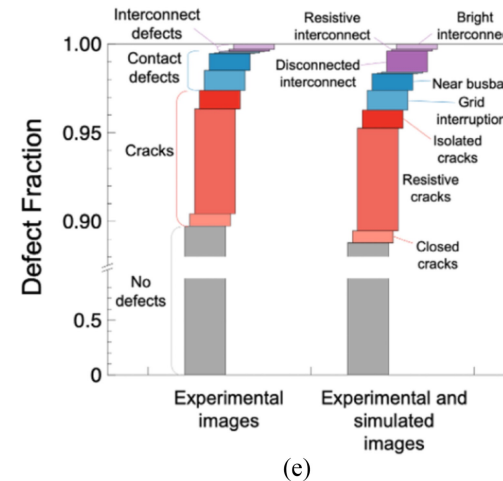
(b)



(c)

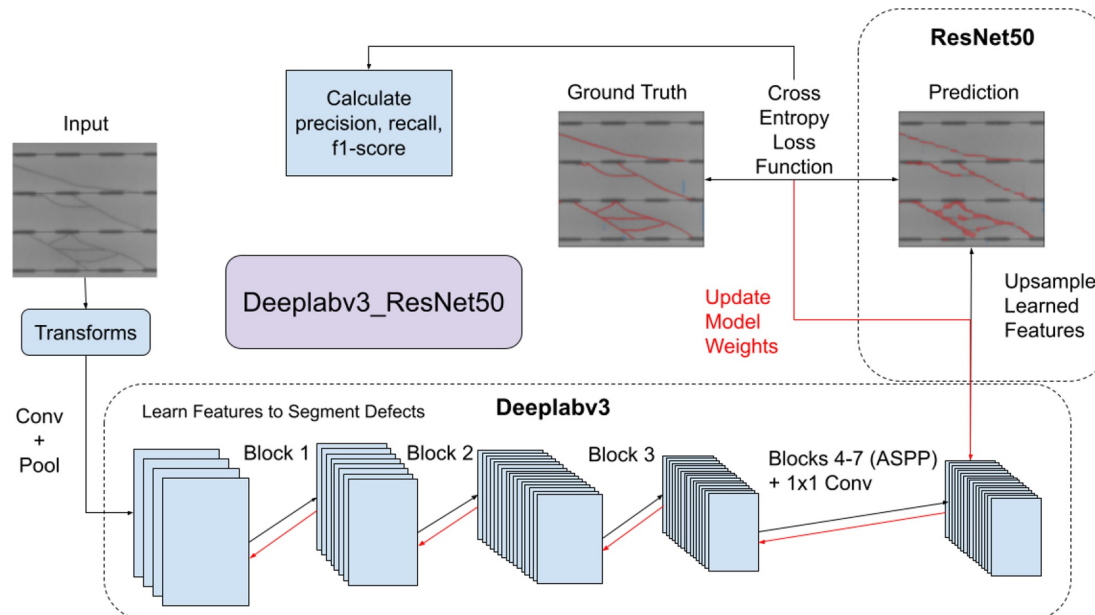


(d)



Automatic defect detection using semantic segmentation

- Input of module EL images
- Indexing each individual cells within the module
- Output percentage of cells with certain type of defect

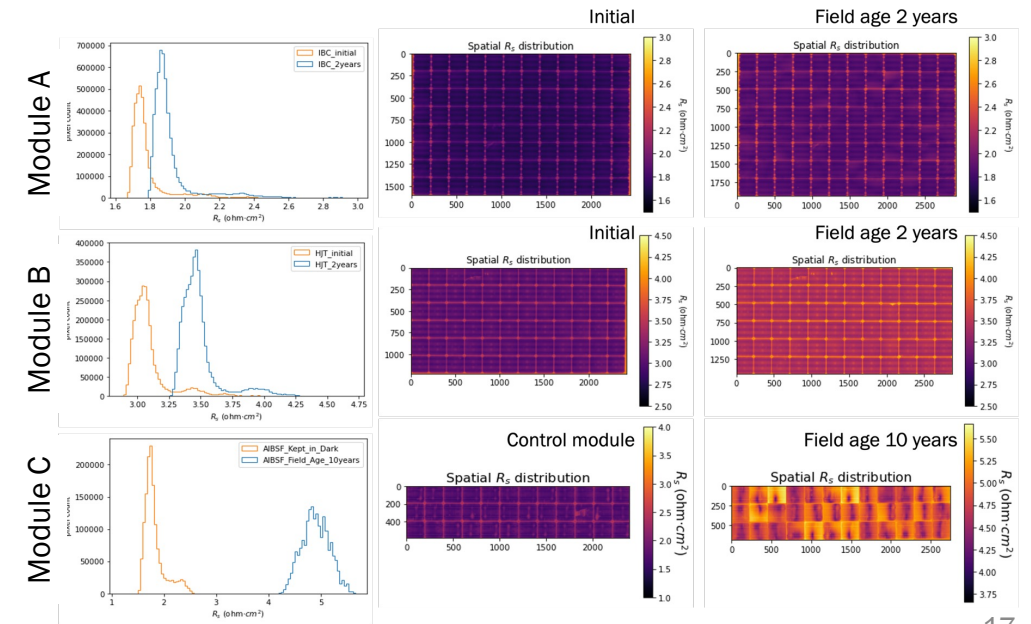
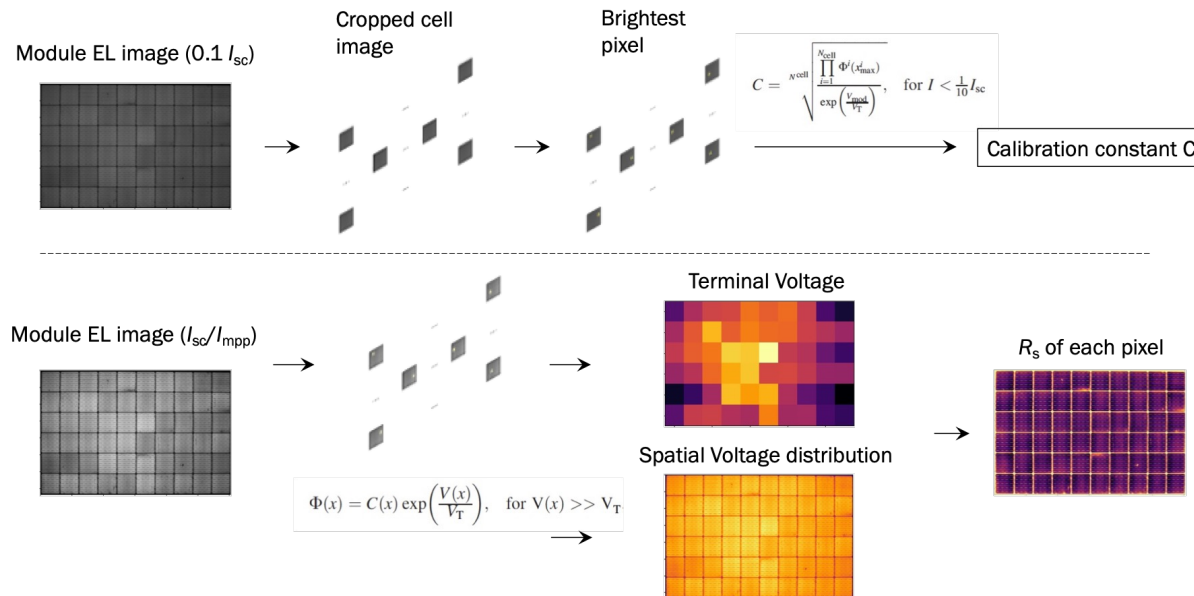
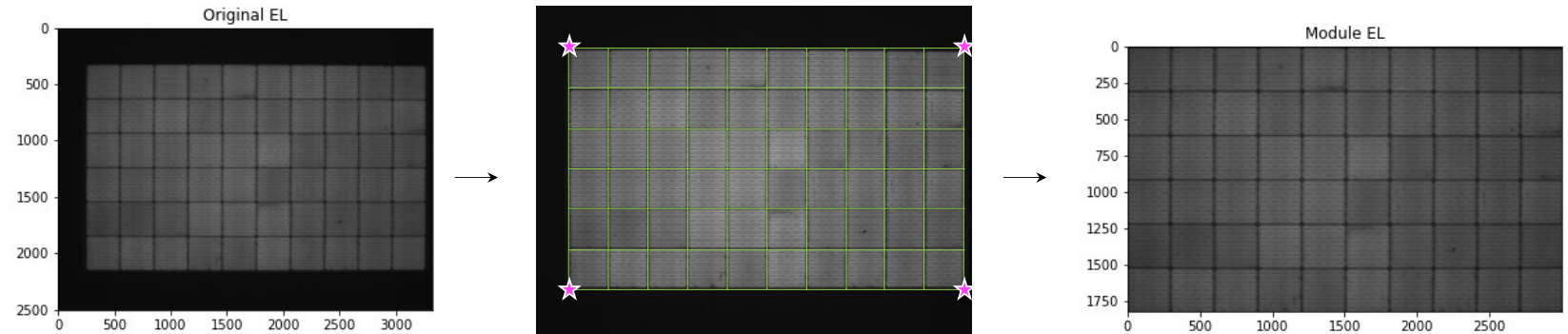


Defect	Modules with Defect	Percent of Total
Backsheet bubbling	2	1.3
Front delamination	156	100
Backsheet burn marks	10	6.4
Backsheet bumps	27	17.3
ARC corrosion	80	51.3
Snail trails	30	19.2

Degradation Analysis – EL imaging

Streamline series resistance imaging

- Input of minimum of 2 EL images
- Automatically calculate terminal voltage and spatial voltage distribution at pixel level
- Output module R_s images



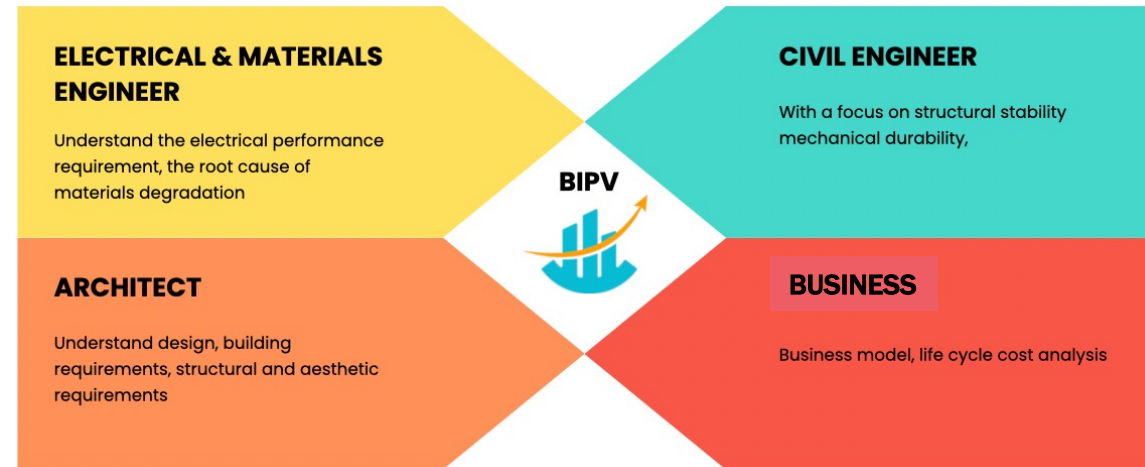
Challenges and Opportunities

- Different BIPV products

- Foil
- Tile
- Module
- Shingles
- Glazing

- Difference between BIPV and PV

- No specific standards for BIPV
- Understanding root cause vs. global degradation rate estimation
- Challenge with long-term field testing



Thanks! Questions?

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Funding



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